

(OOPS!) - OOPS! - Ontology Pitfall Scanner

Contact information

Address: Main researchers:

- M. CARMEN SUAREZ DE FIGUEROA BAONZA

mdelcarmen.suarezdefigueroa@upm.es

- ASUNCION DE MARIA GOMEZ PEREZ

asunciondemaria.gomez@upm.es

- MARIA POVEDA VILLALON

m.poveda@upm.es

Technological Offers type

[Software](#)

Research and innovation areas

- [Tecnologías digitales](#), [Inteligencia Artificial](#), [ciberseguridad](#), [5G](#), [robótica](#)

Where?

[Artificial Intelligence R&I Centre \(AI.nnovation Space\)](#) [Ontology Engineering Group](#)

Software description

A tool directed at validating ontologies. OOPS! specifically makes it possible to analyse ontologies to detect some of the errors that usually come up during ontology development. In this sense, OOPS! carries out diagnostics on the ontology independently of its domain or modelling requirements. Using the diagnostics, OOPS! generates a series of notifications, indicating which elements errors may be being committed in.

Reference

M-009445/2012